

PATENT  
450100-05081

**IN THE UNITED STATES PATENT AND TRADEMARK OFFICE**

Applicants: Takaya HOSHINO et al.  
International Application No.: PCT/JP2004/006691  
International Filing Date: May 12, 2004  
For: MOTION COMPENSATION DEVICE AND METHOD

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Enclosed are copies of the publications, which were cited in the International Search Report of International Application No. PCT/JP2004/006691. Also enclosed is a copy of Form PTO-1449 and the International Search Report.

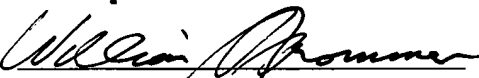
**REMARKS**

Entry of this Information Disclosure Statement and an early examination on the merits are respectfully solicited.

Please charge any additional fees to Deposit Account No. 50-0320.

Respectfully submitted,

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Enclosures

Based on Form PTO-1449 (3/90)  LIST OF REFERENCES CITED BY APPLICANT (Use several sheets if necessary)	ATTY. DOCKET NO. 450100-05081	SERIAL NO. 19/52130 Filed Concurrently Herewith
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U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
	AA	4, 771, 331	09/13/88	Bierling et al.			
	AB	6, 240, 211	05/29/01	Mancuso et al.			
	AC	5, 532, 750	07/02/96	De Haan et al.			
	AD						
	AE						
	AF						

FOREIGN PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES NO
	AG	JP 11-298861	10/29/99	Japan			
	AH	JP 62-213392	09/19/87	Japan			
	AI	EP 0 236 519	09/16/87	Europe			
	AJ	JP 8-84293	03/26/96	Japan			
	AK	EP 0 675 643	10/04/95	Europe			
	AL	JP 11-168703	06/22/99	Japan			
	AM	EP 0 874 523	10/28/98	Europe			
	AN	JP 10-501953	02/17/98	Japan			
	AO	WO 96/33571	10/24/96	PCT			
	AP	JP 6-500910	01/27/94	Japan			
	AQ	WO 93/00773	01/07/93	PCT			
	AR	JP 5-137122	06/01/93	Japan			
	AS	EP 0 542 259	05/19/93	Europe			
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